

## 12A, 650V N-CHANNEL MOSFET

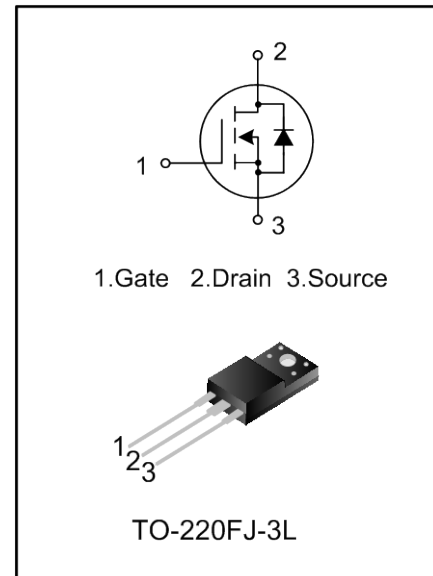
### GENERAL DESCRIPTION

SVF12N65CFJ is an N-channel enhancement mode power MOS field effect transistor which is produced using Silan proprietary F-Cell™ high-voltage planar VDMOS technology. The improved process and cell structure have been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

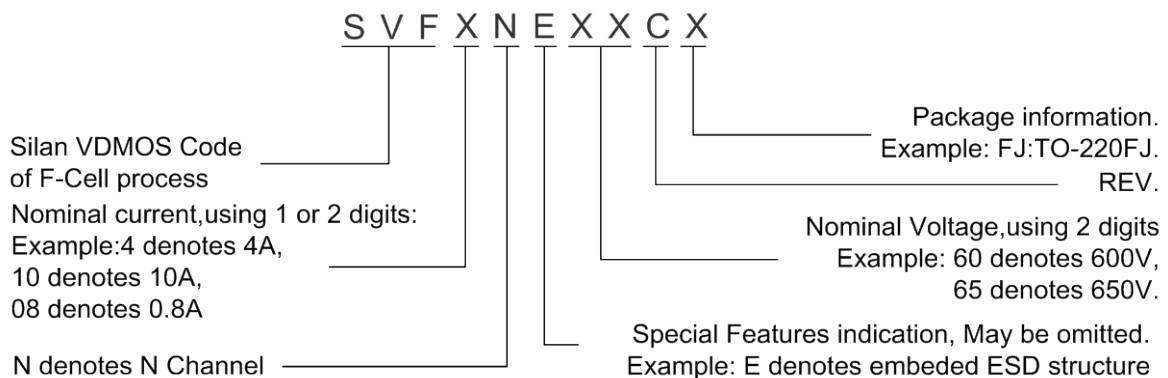
These devices are widely used in AC-DC power supplies, DC-DC converters and H-bridge PWM motor drivers.

### FEATURES

- ◆ 12A,650V, $R_{DS(on)(typ.)}=0.64\Omega@V_{GS}=10V$
- ◆ Low gate charge
- ◆ Low Crss
- ◆ Fast switching
- ◆ Improved dv/dt capability



### NOMENCLATURE



### ORDERING INFORMATION

| Part No.    | Package     | Marking  | Hazardous Substance Control | Packing |
|-------------|-------------|----------|-----------------------------|---------|
| SVF12N65CFJ | TO-220FJ-3L | 12N65CFJ | Halogen free                | Tube    |

**ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C unless otherwise noted)**

| Characteristics                         |                        | Symbol           | Ratings  | Unit |
|---|------------------------|------------------|----------|------|
| Drain-Source Voltage                    |                        | V <sub>DS</sub>  | 650      | V    |
| Gate-Source Voltage                     |                        | V <sub>GS</sub>  | ±30      | V    |
| Drain Current                           | T <sub>C</sub> = 25°C  | I <sub>D</sub>   | 12       | A    |
|   | T <sub>C</sub> = 100°C |                  | 7.6      |      |
| Drain Current Pulsed                    |                        | I <sub>DM</sub>  | 48       | A    |
| Power Dissipation(T <sub>C</sub> =25°C) |                        | P <sub>D</sub>   | 51       | W    |
| -Derate above 25°C                      |                        |                  | 0.41     |      |
| Single Pulsed Avalanche Energy (Note 1) |                        | E <sub>AS</sub>  | 790      | mJ   |
| Operation Junction Temperature Range    |                        | T <sub>J</sub>   | -55~+150 | °C   |
| Storage Temperature Range               |                        | T <sub>stg</sub> | -55~+150 | °C   |

**THERMAL CHARACTERISTICS**

| Characteristics                         | Symbol           | Ratings | Unit |
|---|------------------|---------|------|
| Thermal Resistance, Junction-to-Case    | R <sub>θJC</sub> | 2.44    | °C/W |
| Thermal Resistance, Junction-to-Ambient | R <sub>θJA</sub> | 62.5    | °C/W |

**ELECTRICAL CHARACTERISTICS (T<sub>C</sub>=25°C unless otherwise noted)**

| Characteristics                          | Symbol              | Test conditions  | Min. | Typ.  | Max. | Unit |
|--|---------------------|--|------|-------|------|------|
| Drain -Source Breakdown Voltage          | BV <sub>DSS</sub>   | V <sub>GS</sub> =0V, I <sub>D</sub> =250μA   | 650  | --    | --   | V    |
| Drain-Source Leakage Current             | I <sub>DSS</sub>    | V <sub>DS</sub> =650V, V <sub>GS</sub> =0V   | --   | --    | 1.0  | μA   |
| Gate-Source Leakage Current              | I <sub>GSS</sub>    | V <sub>GS</sub> =±30V, V <sub>DS</sub> =0V   | --   | --    | ±100 | nA   |
| Gate Threshold Voltage                   | V <sub>GS(th)</sub> | V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> =250μA  | 2.0  | --    | 4.0  | V    |
| Static Drain- Source On State Resistance | R <sub>DS(on)</sub> | V <sub>GS</sub> =10V, I <sub>D</sub> =6.0A   | --   | 0.64  | 0.8  | Ω    |
| Input Capacitance                        | C <sub>iss</sub>    | V <sub>DS</sub> =25V, V <sub>GS</sub> =0V,<br>f=1.0MHz   | --   | 1390  | --   | pF   |
| Output Capacitance                       | C <sub>oss</sub>    |  | --   | 156   | --   |      |
| Reverse Transfer Capacitance             | C <sub>rss</sub>    |  | --   | 15.2  | --   |      |
| Turn-on Delay Time                       | t <sub>d(on)</sub>  | V <sub>DD</sub> =325V, I <sub>D</sub> =12A,<br>V <sub>GS</sub> =10V, R <sub>G</sub> =24Ω<br><br>(Note 2,3) | --   | 25.80 | --   | ns   |
| Turn-on Rise Time                        | t <sub>r</sub>      |  | --   | 46.40 | --   |      |
| Turn-off Delay Time                      | t <sub>d(off)</sub> |  | --   | 82.26 | --   |      |
| Turn-off Fall Time                       | t <sub>f</sub>      |  | --   | 42.13 | --   |      |
| Total Gate Charge                        | Q <sub>g</sub>      | V <sub>DS</sub> =520V, I <sub>D</sub> =12A,<br>V <sub>GS</sub> =10V<br><br>(Note 2,3)                      | --   | 32.5  | --   | nC   |
| Gate-Source Charge                       | Q <sub>gs</sub>     |  | --   | 7.37  | --   |      |
| Gate-Drain Charge                        | Q <sub>gd</sub>     |  | --   | 14.2  | --   |      |

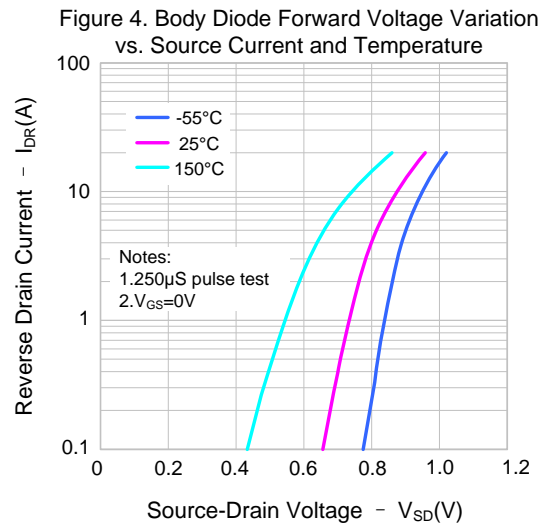
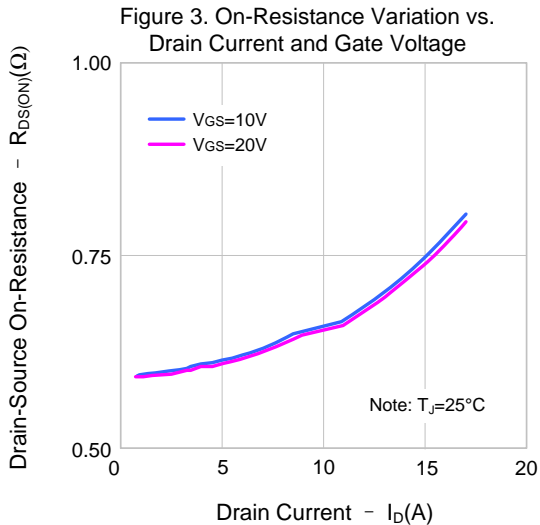
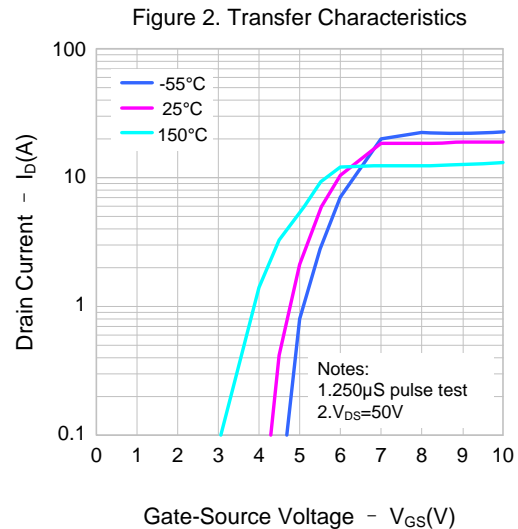
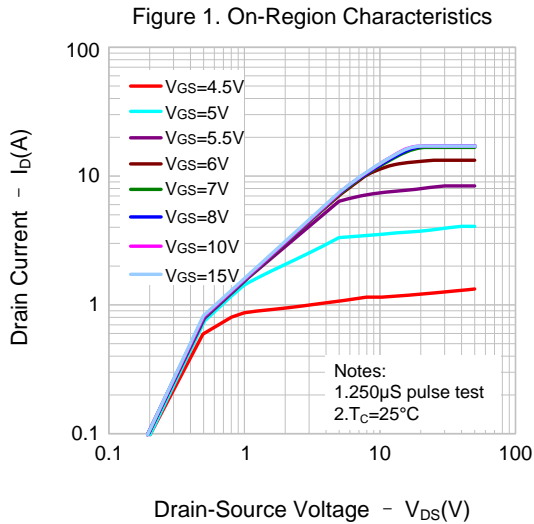
**SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

| Characteristics           | Symbol   | Test conditions               | Min. | Typ. | Max. | Unit    |
|---------------------------|----------|-------------------------------|------|------|------|---------|
| Continuous Source Current | $I_S$    | Integral Reverse P-N Junction | --   | --   | 12   | A       |
| Pulsed Source Current     | $I_{SM}$ | Diode in the MOSFET           | --   | --   | 48   |         |
| Diode Forward Voltage     | $V_{SD}$ | $I_S=12A, V_{GS}=0V$          | --   | --   | 1.4  | V       |
| Reverse Recovery Time     | $T_{rr}$ | $I_S=12A, V_{GS}=0V,$         | --   | 562  | --   | ns      |
| Reverse Recovery Charge   | $Q_{rr}$ | $di_F/dt=100A/\mu S$ (Note 2) | --   | 5.12 | --   | $\mu C$ |

**Notes:**

1.  $L=30mH, I_{AS}=6.0A, V_{DD}=100V, R_G=25\Omega,$  starting  $T_J=25^\circ C;$
2. Pulse Test: Pulse width  $\leq 300\mu s,$  Duty cycle  $\leq 2\%;$
3. Essentially independent of operating temperature.

**TYPICAL CHARACTERISTICS**



**TYPICAL CHARACTERISTICS (continued)**

Figure 5. Capacitance Characteristics

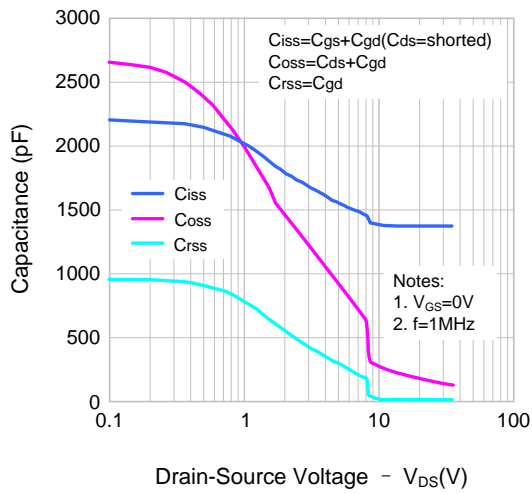


Figure 6. Gate Charge Characteristics

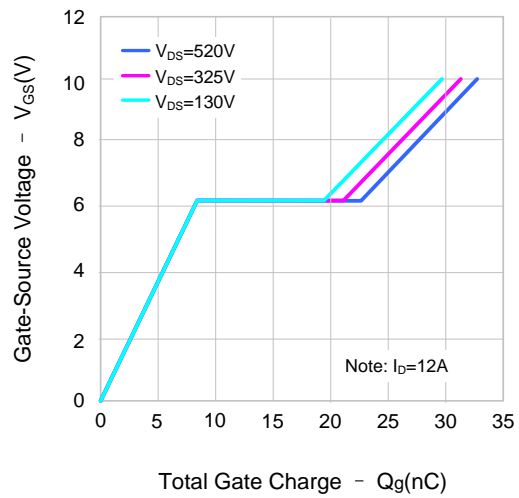


Figure 7. Breakdown Voltage Variation vs. Temperature

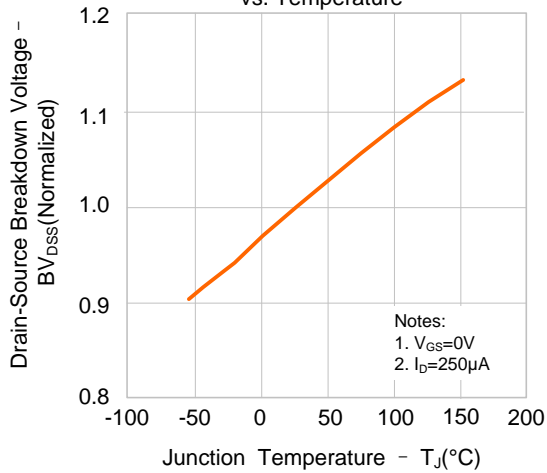


Figure 8. On-resistance vs. Temperature

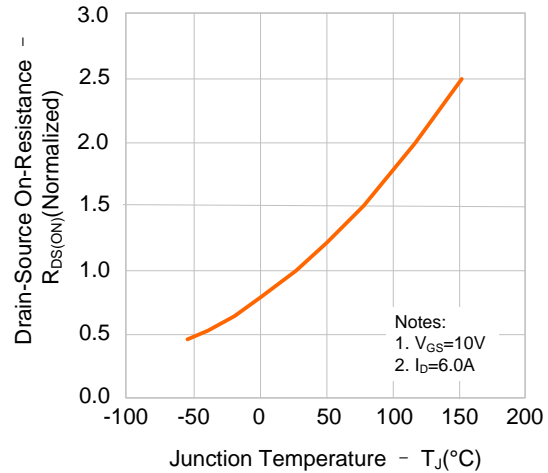


Figure 9. Max. Safe Operating Area

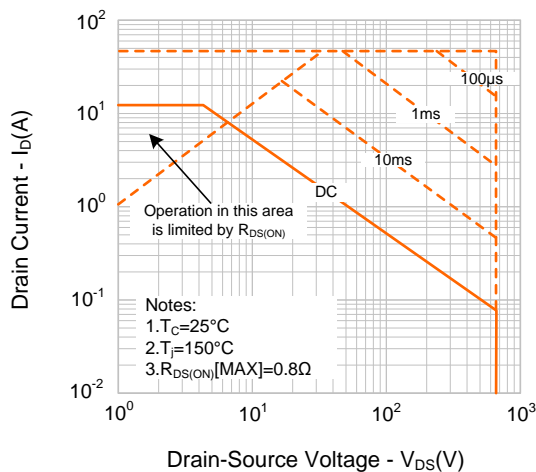
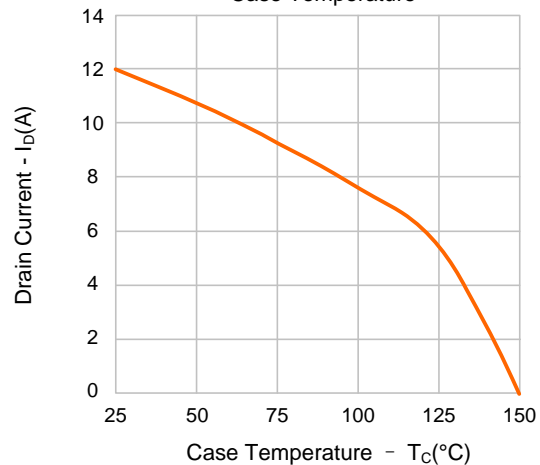
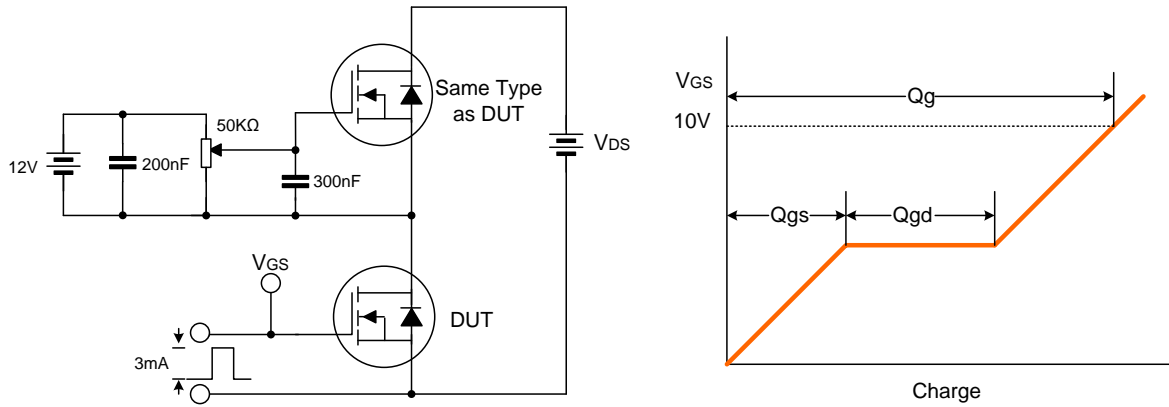


Figure 10. Max. Drain Current vs. Case Temperature

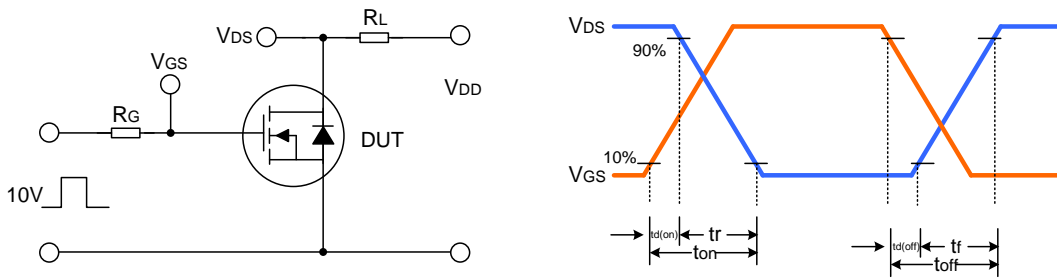


**TYPICAL TEST CIRCUIT**

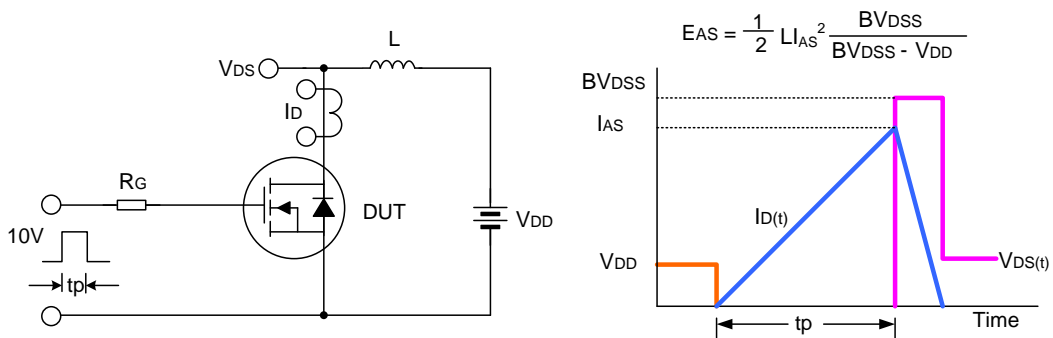
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform

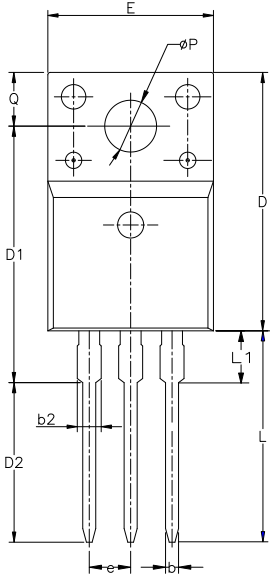


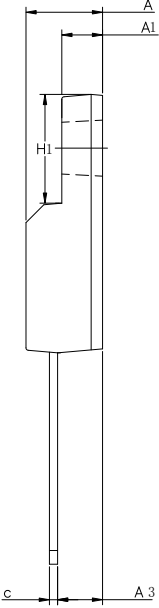
Unclamped Inductive Switching Test Circuit & Waveform



**PACKAGE OUTLINE**

|                    |                 |
|--------------------|-----------------|
| <b>TO-220FJ-3L</b> | <b>UNIT: mm</b> |
|--------------------|-----------------|





| SYMBOL | MIN     | NOM   | MAX   |
|--------|---------|-------|-------|
| A      | 4.42    | 4.70  | 5.02  |
| A1     | 2.30    | 2.54  | 2.80  |
| A3     | 2.50    | 2.76  | 3.10  |
| b      | 0.55    | 0.70  | 0.85  |
| b2     | —       | —     | 1.29  |
| c      | 0.35    | 0.50  | 0.65  |
| D      | 15.25   | 15.87 | 16.25 |
| D1     | 13.97   | 14.47 | 14.97 |
| D2     | 10.58   | 11.08 | 11.58 |
| E      | 9.73    | 10.16 | 10.36 |
| e      | 2.54BCS |       |       |
| H1     | 6.40    | 6.68  | 7.00  |
| L      | 12.48   | 12.98 | 13.48 |
| L1     | —       | —     | 2.00  |
| øP     | 3.00    | 3.18  | 3.40  |
| Q      | 3.05    | 3.30  | 3.55  |

**Disclaimer :**

- Silan reserves the right to make changes to the information herein for the improvement of the design and performance without prior notice! Customers should obtain the latest relevant information before placing orders and should verify that such information is complete and current.
- All semiconductor products malfunction or fail with some probability under special conditions. When using Silan products in system design or complete machine manufacturing, it is the responsibility of the buyer to comply with the safety standards strictly and take essential measures to avoid situations in which a malfunction or failure of such Silan products could cause loss of body injury or damage to property.
- Silan will supply the best possible product for customers!

---

Part No.: SVF12N65CFJ Document Type: Datasheet  
Copyright: HANGZHOU SILAN MICROELECTRONICS CO.,LTD Website: <http://www.silan.com.cn>

---

Rev.: 1.3 Author: Yin Zi

Revision History:

1. Modify the Typical Characteristics

---

Rev.: 1.2 Author: Yin Zi

Revision History:

1. Modify the package information of TO-220FJ-3L

---

Rev.: 1.1 Author: Yin Zi

Revision History:

1. Modify the thermal characteristics

---

Rev.: 1.0 Author: Yin Zi

Revision History:

1. First release
- 
-